

<b>Notice of References Cited</b>	Application/Control No. 10/530,012	Applicant(s)/Patent Under Reexamination WATJEN, FRANK	
	Examiner Celia Chang	Art Unit 1625	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,376,673	04-2002	Moldt et al.	546/229
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	R					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Christensen et al. CA81:152011 (1974) RN 54087-81-9
	V	Moldt et al. Ca 130:13920 (1998) RN 216009-52-8
	W	Waetjen CA 140:406740 (2004)
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.